

<b>Notice of References Cited</b>	Application/Control No. 10/602,887		Applicant(s)/Patent Under Reexamination KANAZAWA ET AL.	
	Examiner Dieu Hien T. Duong		Art Unit 2821	Page 1 of 1

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*	A	US-5,463,287	10-1995	Kurihara et al.	315/307
*	B	US-6,127,788	10-2000	Yamamoto et al.	315/307
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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